

Bundesamt für Eich- und Vermessungswesen (BEV) Vienna, Austria

Report on on-going CCL Key Comparison for the year 2017

Comparison of optical frequency and wavelength standards

CCL-K11

Final

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1 Document control

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2 Introduction

The metrological equivalence of national measurement standards and of calibration certificates issued by national metrology institutes is established by a set of key and supplementary comparisons chosen and organized by the Consultative Committees of the CIPM or by the regional metrology organizations in collaboration with the Consultative Committees.

The BIPM.L-K10 (K10) key comparison was initiated in 1993 to provide a basis for demonstrating equivalence of national realizations of wavelength-standards used for the realization of the definition of the metre according to the method (c) in what was called the Mise en Pratique (MeP, refers to the document "Practical realization of the definition of the metre"). Such a comparison seemed of particular importance since the whole field of dimensional metrology had to be traceable to such realizations of the metre. The K10 comparison took only the 633 nm He-Ne standards into consideration. The measurand of the comparison was the difference of the average frequency of the hyperfine components d, e, f, and g in the R(127) 11-5 line as obtained by matrix measurements. The frequency of the reference laser BIPM4 was used as the key comparison reference value, representing the value recommended in the MeP.

The situation for realization of the SI-metre has changed due to the introduction of new techniques for absolute frequency measurements. This has opened up the alternative method (b) in the MeP to realize a frequency/wavelength standard traceable to the SI-second. The practical consequences of this development are that at least two methods are at the moment being used to realize the metre, and that standards of different wavelengths, important for dimensional metrology applications, can now demonstrate traceability with relative ease. Considering these circumstances the 11th CCL meeting which was held in October 2003 at the BIPM decided to close the K10 comparison and initiate a new key comparison named BIPM.L-K11. First measurements in BIPM.L-K11 were made at the BIPM in May 2004. Results from BIPM.L-K10 and BIPM.L-K11 can be found at http://kcdb.bipm.org.

Subsequently, the CIPM has decided, that the comb-related work, which used to provide external services, should stop at the BIPM at the end of 2006. This decision had direct implications on the activity which supported the BIPM.L-K11 that consequently were closed down at the end of year 2006. A proposal for a new scheme for the comparison, based on a group of node-laboratories in the different RMOs and piloted by the Bundesamt für Eich- und Vermessungswesen (BEV, Austria) was therefore made. This proposal, which had been agreed on by the President of the CCL, was given support by the CIPM at its 95th meeting and was endorsed by the 13th meeting of CCL in September 2007. The technical protocol (available from the BIPM web page) defines the procedures to follow in this new comparison, now transferred to the CCL, and named CCL-K11.

This document constitutes the ninth final report for the ongoing key comparison CCL-K11.

3 Organization

3.1 Participants

	Table 1. List of	participant	and node	laboratories and	their contacts.
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Laboratory	Contact person, Laboratory	Phone, Fax, email
Code		
UME Ersoy Şahin		Tel. +90 262 679 50 00
	National Metrology Institute of Turkey (TÜBİTAK-	e-mail: ersoy.sahin@tubitak.gov.tr
	UME)	
	Tübitak Gebze Yerleşkesi, P.K. 41470 Gebze/Kocaeli-	
	Turkey	
BEV	Michael Matus	Tel. +43 1 21110 826540
(pilot,	Bundesamt für Eich- und Vermessungswesen (BEV)	Fax +43 1 21110 82996875
node)	Arltgasse 35, 1160 Wien	e-mail: michael.matus@bev.gv.at
	Austria	
BIPM	Lennart Robertsson	Tel. +33 1 45 07 70 53
(observer)	BIPM	Fax +33 1 45 34 20 21
	Pavillon de Breteuil, 92312 Sèvres	e-mail: lroberts@bipm.org
	France	

3.2 Schedule

Table 2 lists the measurements in chronological order, specifying the participants, the places and the dates. It is a characteristic of this comparison to receive the data immediately after completing the measurements which are performed in the respective node or host laboratories. For the period 2017 a single participant took part in the comparison only.

 Table 2. Schedule of the comparison.

RMO	Laboratory (country code)	Date of measurement	Node laboratory (place of measurements)	Comments
EURAMET	UME (TR)	December 2017	BEV	-

4 Artefacts

4.1 Description of artefacts

The artefact in this campaign is an iodine stabilized HeNe-lasers at $\lambda \approx 633$ nm, stabilized on the f component of the ¹²⁷I₂ R(127) 11-5 transition. The designation of the artefact, as chosen by the owner, is given in table 3.

Table 3. Artefacts participating.						
Laboratory (country code)	Designation of standard	Description				
UME (TR)	UME-L3	MeP, build by laboratory				

Table 3. Artefacts participating.

5 Measuring instructions

5.1 Measurands

Measurements reported here were performed according to the so-called method m1 (Absolute frequency measurement traceable to the realisation of the SI second). Setup of the node laboratory is outlined in the appendix 1 of this report.

Initially to the actual measurements each participating laboratory had to state:

- The expected frequency of the standard, *f*_e. This should normally be the frequency used in their calibration service. It is either the recommended value or a value determined by some other means.
- The standard uncertainty u_e of the expected value. This should be a value compatible with the uncertainty given in the CMC for this service.
- The operational parameters used to obtain the two values mentioned above (if applicable).
- Sensitivity coefficients with uncertainties for parameters appearing in the uncertainty budget for the standard (if applicable).

The stated frequency f_e is the actual measurand in this type of key comparison. It is compared on a per lab basis with the measured frequency f_m possibly corrected to the reference operational parameters as given below. One has to note, that the comparison is blind; the participant is not told the result of the measurement before stating his value for f_e .

The standard uncertainty of the determined frequency is composed of two parts, one from the frequency measurement, u_0 , and one from the uncertainty in the settings of the working (and other) parameters, u_p . The latter, the uncertainties related to the standard itself are to be estimated by each operator in accordance with their quality system. The uncertainty stemming from the measurements, u_0 , is estimated by the operator of the experiment alone, or together with personnel involved in the comparison, again in accordance with a quality procedure. These uncertainties are reported in sections D8 and D9 (of the Technical Protocol) and are given as standard uncertainties following GUM practice. The combined uncertainty of u_0 and u_p , u_m , reported in D10 (of the Technical Protocol) are given as the root sum squares of u_0 and u_p .

Table 4 gives the values used for the most important working parameters for the respective laser. Additional information can be found in the appendix.

Table 4. Working parameter values for the standard with estimated standard uncertainties in parenthesis as given in the measurement report included in the appendix.

Standard	Power	Modulation width	I₂ cold-finger	Cell wall
	in μW	(peak to peak) in MHz	temperature in °C	temperature in °C
UME-L3	139 (3)	6,0 (0,1)	15,0 (0,1)	20 (3)

6.1 Results and standard uncertainties as reported by participants

The stated frequencies f_e and the measured frequencies f_0 (see section 7) and f_m are given in table 5. The allocated standard uncertainties u_e , u_0 and u_m , respectively, are included in parenthesis. Both participants estimate f_e and u_e by absolute laser frequency calibrations performed at their home labs. Both have respective CMC entries for comb-measurement services.

The data from table 5 are used to calculate the final results according to equations (5-7). The results are given in table 6 and figure 1, respectively.

Table 5. Expected frequency f_e , measured (uncorrected) frequency f_0 , and measured frequency, corrected for influence of operational parameters f_m , together with the respective standard uncertainties of the values.

Standard	All frequence	All frequencies given are offset by 473 612 353 MHz		
Stanuaru	$f_{\rm e}\left(u_{\rm e}\right)$ / kHz	$f_0\left(u_0 ight)$ / kHz	$f_{\rm m}\left(u_{\rm m} ight)$ / kHz	
UME-L3	596,0 (3)	594,27 (0,07)	594,07 (1,32)	

Table 6. Degree of equivalence and E_n value for the standard.

Standard	$\Delta f_{ m r}$	$U_{\rm r} = 2u_{\rm r}$	$E_{\rm n} = \Delta f_{\rm r} / U_{\rm r}$
UME-L3	+4,1·10 ⁻¹²	13,8·10 ⁻¹²	+0,29



Figure 1. Relative degree of equivalence for the standard. Error bars represent the relative expanded (for k=2) uncertainties $U_{\rm r}(i)$.

7 Analysis

7.1 Calculation of the KCRV

It is a distinctive feature of this key comparison, that the KCRV is determined on a per participant basis. Thus each participant has its own KCRV which is used to test consistency.

Denote the measured (uncorrected) frequency f_0 with standard uncertainty u_0 , and the measured frequency, corrected for influence of operational parameters f_m with standard uncertainty u_m . Then the following holds:

$$f_{\rm m} = f_0 - \delta \tag{1}$$

The symbol δ denotes the condensed information about the influence of the actual working parameters and other quantities on the laser frequency. A linear model is commonly used:

$$\delta = \sum_{i} s_{i} \cdot \Delta x_{i} + \sum_{i} \delta_{i}$$
⁽²⁾

Where the s_i denote the sensitivity coefficients and Δx_i the deviations of the respective working parameters from the nominal values (care must be taken choosing the correct signs for both quantities). All other influence quantities (e.g. electronic offsets, cavity alignments, etc.) are modelled with the quantities δ_i . These have usually zero expectation values but non-zero uncertainties. The uncertainties are thus derived in a straightforward way as:

$$u_{\rm p} = \sqrt{\sum_{i} (u(s_i) \cdot \Delta x_i)^2 + \sum_{i} (s_i \cdot u(\Delta x_i))^2 + \sum_{i} u(\delta_i)^2}$$
(3)

and

$$u_{\rm m} = \sqrt{u_{\rm p}^2 + u_0^2}$$
 (4)

Denote the expected frequency f_e with standard uncertainty u_e , and the measured frequency, corrected for influence of operational parameters f_m with standard uncertainty u_m . In the nomenclature of the CIPM-MRA f_m (together with its standard uncertainty u_m) denotes the KCRV and f_e (together with its standard uncertainty u_e) the measurand.

For a particular standard, *i*, construct the dimensionless quantities

$$\Delta f_{\rm r}(i) = \frac{f_{\rm e}(i) - f_{\rm m}(i)}{f_{\rm m}(i)} \tag{5}$$

$$u_{\rm r}(i) = \frac{\sqrt{u_{\rm e}^2(i) + u_{\rm m}^2(i)}}{f_{\rm m}(i)}$$
(6)

It must be noted that f_e and f_m should be transferred to the same (usually nominal) working parameters for the standard, which would be expected to coincide with those for which f_e is valid if no other instructions are given by the participating laboratory.

7.2 Calculation of Degrees of Equivalence

To test consistency between the measured values and the expected ones, hypothesis testing at a confidence level of 95 % is to be performed. The result will serve as a basis for the review of the CMC and indicate the compatibility with the claimed capabilities. In this framework the "degree of equivalence" (DoE) can be obtained in the usual way. Thus the (relative) DoE is Δf_r (equ. 5) with it's standard uncertainty u_r (equ. 6). The consistency can thus be checked by the following condition:

$$-1 \leq E_{\rm n} = \frac{\Delta f_{\rm r}(i)}{U_{\rm r}(i)} \leq 1 \quad \text{with} \quad U_{\rm r}(i) = 2 \cdot u_{\rm r}(i)$$
(7)

As discussed at the 14th CCL meeting, June 2009, it is neither necessary nor useful to determine a pairwise degree of equivalence. For all results reported the expanded uncertainty to a 95 % confidence level can be obtained by multiplying the standard uncertainties with k = 2.

7.3 Discussion of results

Frequency measurements have been carried out on one national wavelength standard. A good agreement between the stated and the measured frequency values was found.

The participant has respective CMC for this kind of service. The uncertainty stated in this comparison is equal to or smaller than the CMC uncertainty. The homogenized data is summarized in table 7.

Table 7. Relative expanded uncertainties stated in this comparison versus published uncertainties in Appendix C of the KCDB. All values are recalculated to multiples of 10^{-12} for ease of assessment.

Laboratory (country code)	$U_{\rm e}=2u_{\rm e}$	$U_{ m CMC}$
UME (TR)	13,8·10 ⁻¹²	50,7·10 ⁻¹²

7.4 Linking of result to other comparisons

Plotting the DoE of all participants in the same graph links the results of this on-going key comparison as shown in Figure 2. This is possible even for different nominal frequencies since the DoE are defined as relative quantities.



Figure 2. Relative degree of equivalence for all standards taking part in CCL-K11 since the start of this comparison. Error bars represent the relative expanded (for k=2) uncertainties $U_r(i)$. The years on top of the plot indicate the respective final report.

Appendix A Equipment and measuring processes of the participants

Details on the individual equipment and standards can be found in the measurement reports in the appendix 1 of the supplementary data to this report. These files are electronic copies; the respective node laboratories keep the signed originals.